February 2006

## FAIRCHILD

SEMICONDUCTOR®

# FDS8884 N-Channel PowerTrench<sup>®</sup> MOSFET

### **30V, 8.5A, 23m**Ω

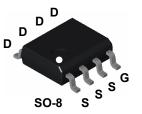
## **General Descriptions**

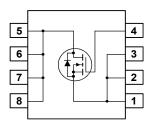
This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low  $r_{DS(on)}$  and fast switching speed.

## Features

- Max  $r_{DS(on)} = 23m\Omega$  at  $V_{GS} = 10V$ ,  $I_D = 8.5A$
- Max  $r_{DS(on)} = 30m\Omega$  at  $V_{GS} = 4.5V$ ,  $I_D = 7.5A$
- Low gate charge
- 100% R<sub>G</sub> Tested
- RoHS Compliant







#### MOSFET Maximum Ratings T<sub>A</sub> = 25°C unless otherwise noted

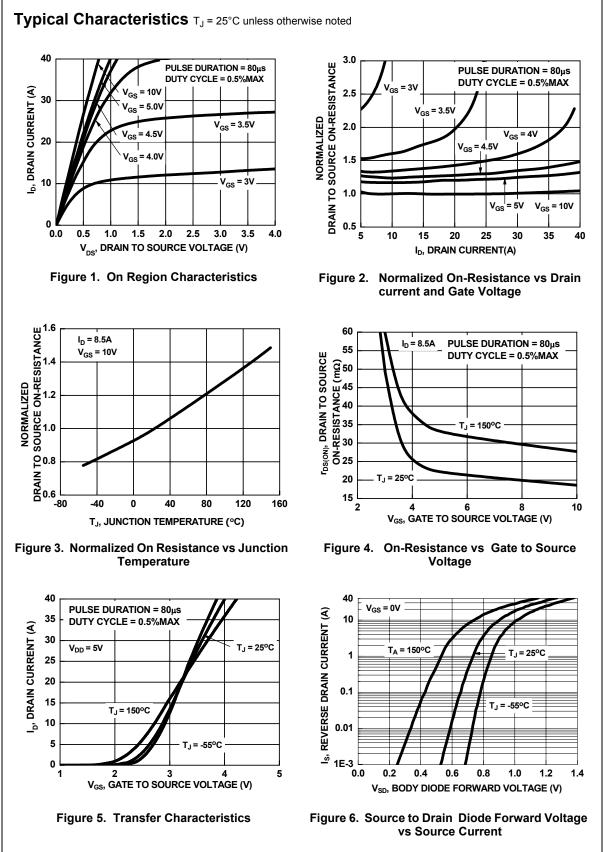
| Symbol                            | Parameter                               |           | Ratings    | Units |
|-----------------------------------|---|-----------|------------|-------|
| V <sub>DS</sub>                   | Drain to Source Voltage                 |           | 30         | V     |
| V <sub>GS</sub>                   | Gate to Source Voltage                  |           | ±20        | V     |
| I                                 | Drain Current Continuous                | (Note 1a) | 8.5        | А     |
| D                                 | Pulsed                                  |           | 40         | Α     |
| E <sub>AS</sub>                   | Single Pulse Avalanche Energy           | (Note 2)  | 32         | mJ    |
| 6                                 | Power dissipation                       |           | 2.5        | W     |
| P <sub>D</sub>                    | Derate above 25°C                       |           | 20         | mW/ºC |
| T <sub>J</sub> , T <sub>STG</sub> | Operating and Storage Temperature       |           | -55 to 150 | °C    |
| Therma                            | I Characteristics                       |           |            |       |
| R <sub>0JA</sub>                  | Thermal Resistance, Junction to Ambient | (Note 1a) | 50         | °C/W  |
| $R_{	heta J A}$                   | Thermal Resistance, Junction to Case    | (Note 1)  | 25         | °C/W  |

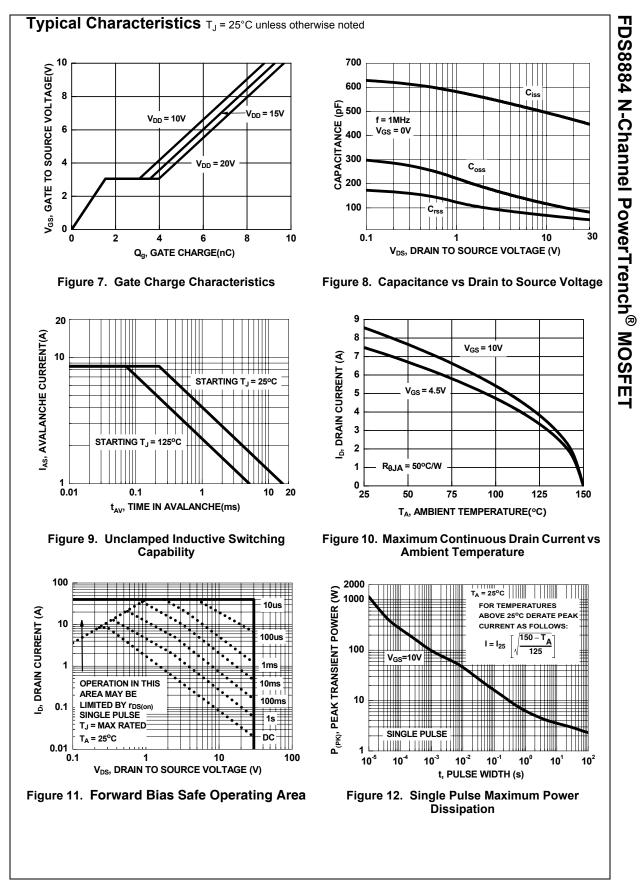
### Package Marking and Ordering Information

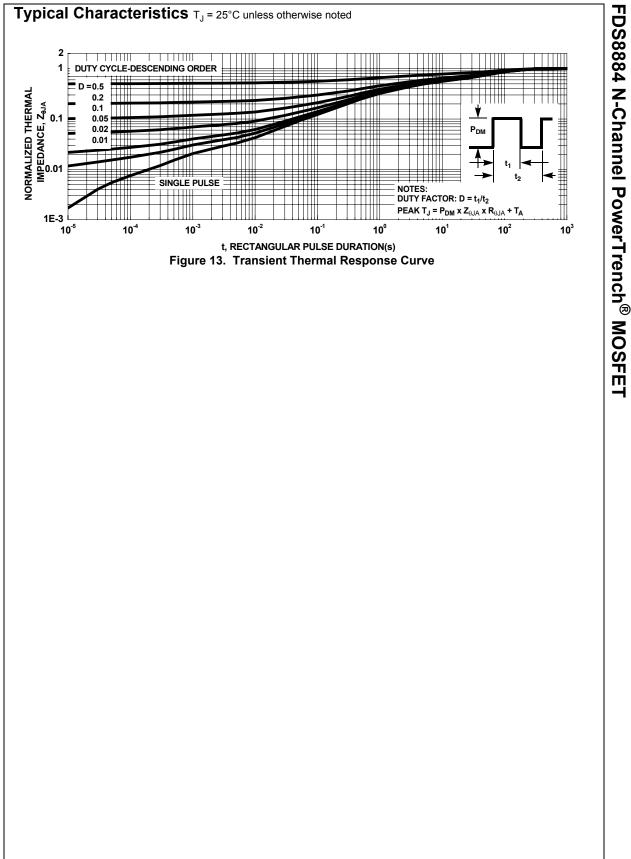
| Device Marking | Device  | Package | Reel Size | Tape Width | Quantity   |
|----------------|---------|---------|-----------|------------|------------|
| FDS8884        | FDS8884 | SO-8    | 330mm     | 12mm       | 2500 units |

| Parameter                         | Test Conditions   | Min  | Тур  | Max   | Units  |
|-----------------------------------|---|--|--|---|--|
| teristics                         |   |  |  |   |  |
| Drain to Source Breakdown Voltage | I <sub>D</sub> = 250μA, V <sub>GS</sub> = 0V  | 30   |  |   | V  |
| Breakdown Voltage Temperature     | $I_D = 250 \mu A$ , referenced to   |  |  |   | -  |
| Coefficient                       | 25°C  | 23   | 23   |   | mV/ºC  |
|                                   | $V_{DS} = 24V$  |  |  | 1   |  |
| Zero Gate Voltage Drain Current   |   |  |  | 250   | μA   |
| Gate to Source Leakage Current    |   |  |  | ±100  | nA   |
| teristics (Note 3)                |   |  |  | 1   | 1  |
| , <i>,</i>                        | $V_{00} = V_{00}$ la = 250µA  | 12   | 17   | 25  | V  |
|                                   |   | 1.2  | 1.7  | 2.5   | -  |
| 5                                 | $1D = 250\mu$ A, referenced to $25^{\circ}$ C   |  | -4.9   |   | mV/ºC  |
|                                   | $V_{CC} = 10V$ , $I_{C} = 8.5A$ .   |  | 19   | 23  |  |
|                                   |   |  | -  | -   |  |
| Drain to Source On Resistance     |   |  |  |   | mΩ   |
|                                   | $T_{\rm J} = 125^{\circ}C$  |  | 26   | 32  |  |
| Characteristics                   |   |  |  |   |  |
|                                   |   |  | 475  | 635   | pF   |
|                                   |   |  |  |   | pF   |
|                                   | f = 1MHz  |  |  | -   | pF   |
|                                   | f – 1MHz  |  |  | -   | Ω  |
|                                   |   |  | 010  |   |  |
|                                   | 1   |  | -  | 10  |  |
|                                   | $V_{DD} = 15V l_{D} = 8.5A$   |  |  |   | ns   |
|                                   |   |  | -  |   | ns   |
|                                   |   |  | 42   | 68  | ns   |
| Fall Time                         |   |  | 21   | 34  | ns   |
| Total Gate Charge                 | V <sub>DS</sub> = 15V, V <sub>GS</sub> = 10V<br>I <sub>D</sub> = 8.5A   |  | 9.2  | 13  | nC   |
| Total Gate Charge                 | $V_{DC} = 15V$ , $V_{CC} = 5V$  |  | 5.0  | 7   | nC   |
| Gate to Source Gate Charge        | $I_{\rm D} = 8.5A$  |  | 1.5  |   | nC   |
| -                                 |   |  | 2.0  |   | nC   |
| -                                 |   |  |  |   |  |
|                                   | I <sub>SD</sub> = 8.5A  |  | 0.9  | 1.25  | V  |
| Source to Drain Diode Voltage     |   |  | 0.8  | 1.0   | V  |
| Reverse Recovery Time             |   |  |  |   | ns   |
|                                   |   |  |  |   | nC   |
|                                   | Zero Gate Voltage Drain Current<br>Gate to Source Leakage Current<br><b>eteristics (Note 3)</b><br>Gate to Source Threshold Voltage<br>Gate to Source Threshold Voltage<br>Temperature Coefficient<br>Drain to Source On Resistance<br>Characteristics<br>Input Capacitance<br>Output Capacitance<br>Reverse Transfer Capacitance<br>Gate Resistance<br><b>Characteristics (Note 3)</b><br>Turn-On Delay Time<br>Rise Time<br>Turn-Off Delay Time<br>Fall Time<br>Total Gate Charge | Zero Gate Voltage Drain Current $V_{DS} = 24V$<br>$V_{GS} = 0V$ $T_J = 125^{\circ}C$ Gate to Source Leakage Current $V_{GS} = \pm 20V$ tteristics (Note 3)Gate to Source Threshold Voltage $V_{GS} = V_{DS}$ , $I_D = 250\mu A$ Gate to Source Threshold Voltage $I_D = 250\mu A$ , referenced to<br>$25^{\circ}C$ Drain to Source On Resistance $V_{GS} = 10V$ , $I_D = 8.5A$ ,<br>$V_{GS} = 10V$ , $I_D = 8.5A$ ,<br>$T_J = 125^{\circ}C$ Input Capacitance $V_{DS} = 15V$ , $V_{GS} = 0V$ ,<br>$f = 1MHz$ Characteristics $f = 1MHz$ Input Capacitance $f = 1MHz$ Gate Resistance $f = 1MHz$ Characteristics (Note 3) $V_{DD} = 15V$ , $I_D = 8.5A$ ,<br>$V_{GS} = 10V$ , $I_D = 8.5A$ Turn-On Delay Time $V_{DS} = 15V$ , $V_{GS} = 33\Omega$ Fail Time $V_{DS} = 15V$ , $V_{GS} = 10V$ Total Gate Charge $V_{DS} = 15V$ , $V_{GS} = 5V$ Gate to Source Gate Charge $I_D = 8.5A$ Gate to Drain Charge $V_{DS} = 15V$ , $V_{GS} = 5V$ Gate to Drain Charge $I_{SD} = 8.5A$ Source to Drain Diode Voltage $I_{SD} = 8.5A$ Reverse Recovery Time $I_F = 8.5A$ , di/dt = 100A/ $\mu$ s | Zero Gate Voltage Drain Current $V_{DS} = 24V$<br>$V_{GS} = 0V$ $T_J = 125^{\circ}C$ Gate to Source Leakage Current $V_{GS} = \pm 20V$ | Zero Gate Voltage Drain Current $V_{DS} = 24V$<br>$V_{GS} = 0V$ $T_J = 125^{\circ}C$ Gate to Source Leakage Current $V_{GS} = \pm 20V$ $V_{GS} = \pm 20V$ tteristics (Note 3)Gate to Source Threshold Voltage $I_D = 250\muA$ , referenced to<br>$25^{\circ}C$ $1.2$ $1.7$ Gate to Source Threshold Voltage $I_D = 250\muA$ , referenced to<br>$25^{\circ}C$ $-4.9$ Drain to Source On Resistance $V_{GS} = 10V, I_D = 8.5A,$<br>$V_{GS} = 10V, I_D = 8.5A,$<br>$T_J = 125^{\circ}C$ 26CharacteristicsInput Capacitance<br>Output Capacitance $V_{DS} = 15V, V_{GS} = 0V,$<br>$f = 1MHz$ 475Output Capacitance<br>Gate Resistance $f = 1MHz$ 0.9Characteristics (Note 3)Turn-On Delay Time<br>Fall Time $V_{DS} = 15V, V_{GS} = 33\Omega$ $42$ Fall Time $V_{DS} = 15V, V_{GS} = 10V$<br>$I_D = 8.5A$ $9$ Total Gate Charge<br>Gate to Source Gate Charge<br>Gate to Drain Charge $V_{DS} = 15V, V_{GS} = 5V$<br>$I_D = 8.5A$ $9.2$ Total Gate Charge<br>Gate to Drain Diode Voltage $I_{SD} = 8.5A$<br>$I_D = 8.5A$ $0.9$ Reverse Recovery Time $I_F = 8.5A, di/dt = 100A/\mu s$ $0.9$ | $\begin{array}{ c c c c c c } \hline V_{DS} = 24V & & & & 1 \\ \hline V_{GS} = 0V & \hline T_J = 125^{\circ}C & & & 250 \\ \hline \end{tabular}$ |

FDS8884 N-Channel PowerTrench<sup>®</sup> MOSFET







#### TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

| ACEx™                                | FAST <sup>®</sup>              | ISOPLANAR™             | PowerSaver™                     | SuperSOT™-6            |
|--------------------------------------|--------------------------------|------------------------|---------------------------------|------------------------|
| ActiveArray™                         | FASTr™                         | LittleFET™             | PowerTrench <sup>®</sup>        | SuperSOT™-8            |
| Bottomless™                          | FPS™                           | MICROCOUPLER™          | QFET <sup>®</sup>               | SyncFET™               |
| Build it Now™                        | FRFET™                         | MicroFET™              | QS™                             | TCM™                   |
| CoolFET™                             | GlobalOptoisolator™            | MicroPak™              | QT Optoelectronics <sup>™</sup> | TinyLogic <sup>®</sup> |
| CROSSVOLT™                           | GTO™                           | MICROWIRE™             | Quiet Series™                   | TINYOPTO™              |
| DOME™                                | HiSeC™                         | MSX™                   | RapidConfigure™                 | TruTranslation™        |
| EcoSPARK™                            | I <sup>2</sup> C™              | MSXPro™                | RapidConnect™                   | UHC™                   |
| E <sup>2</sup> CMOS™                 | i-Lo™                          | OCX™                   | µSerDes™                        | UltraFET®              |
| EnSigna™                             | ImpliedDisconnect <sup>™</sup> | OCXPro™                | ScalarPump™                     | UniFET™                |
| FACT™                                | IntelliMAX™                    | OPTOLOGIC <sup>®</sup> | SILENT SWITCHER®                | VCX™                   |
| FACT Quiet Series™                   |                                | OPTOPLANAR™            | SMART START™                    | Wire™                  |
|                                      |                                | PACMAN™                | SPM™                            |                        |
| Across the board. Around the world.™ |                                | POP™                   | Stealth™                        |                        |
| The Power Franchise <sup>®</sup>     |                                | Power247™              | SuperFET™                       |                        |
| Programmable Active                  | Droop™                         | PowerEdge™             | SuperSOT™-3                     |                        |

#### DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

#### LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user.

2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

| Product Status            | Definition  |  |  |  |
|---------------------------|---|--|--|--|
| Formative or In<br>Design | This datasheet contains the design specifications for<br>product development. Specifications may change in<br>any manner without notice.  |  |  |  |
| First Production          | This datasheet contains preliminary data, and<br>supplementary data will be published at a later date.<br>Fairchild Semiconductor reserves the right to make<br>changes at any time without notice in order to improve<br>design. |  |  |  |
| Full Production           | This datasheet contains final specifications. Fairchild<br>Semiconductor reserves the right to make changes at<br>any time without notice in order to improve design.   |  |  |  |
| Not In Production         | This datasheet contains specifications on a product<br>that has been discontinued by Fairchild semiconductor<br>The datasheet is printed for reference information only.  |  |  |  |
|                           | Formative or In<br>Design<br>First Production<br>Full Production  |  |  |  |

# **PRODUCT STATUS DEFINITIONS**

# **Mouser Electronics**

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

Fairchild Semiconductor: